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PAPER

# Role of interlayer coupling in ultra thin MoS<sub>2</sub>

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The effects of interlayer coupling on the vibrational and electronic properties of ultra thin MoS<sub>2</sub> were studied by *ab initio* calculations. For smaller slab thickness, the interlayer distance is significantly elongated because of reduced interlayer coupling. This explains the anomalous thickness dependence of the lattice vibrations observed by Lee *et al.* (ACS Nano, 2010, 4, 2695). The absence of interlayer coupling in mono-layer MoS<sub>2</sub> induces a transition from direct to indirect band gap behaviour. Our results demonstrate a strong interplay between the intralayer chemical bonding and the interlayer van-der-Waals interaction.

## I. Introduction

It was believed for many years that the existence of a free-standing two-dimensional (2D) crystal is impossible because of thermal fluctuations. However, recent advances in the formation of isolated graphene sheets by mechanical exfoliation of van-der-Waals (vdW) bonded graphite have opened up new possibilities for the investigation of 2D systems.<sup>1</sup> The transition metal dichalcogenide semiconductor MoS<sub>2</sub>, which is build up of vdW bonded S–Mo–S layers, has attracted great interest because of its distinctive electronic, optical and catalytic properties, as well as its importance for dry lubrication.<sup>2–4</sup> Because of the relatively weak interaction between these layers and the strong intralayer interaction, the formation of ultra thin crystals of MoS<sub>2</sub> has been achieved by the micromechanical cleavage technique.<sup>5–8</sup> A largely unexplored question is how the weak vdW-like interlayer interaction affects the intralayer bonding, lattice vibrations and electronic properties of stacked few-layer MoS<sub>2</sub>.

By analyzing the Raman spectra of mono-layer and few-layer MoS<sub>2</sub> exfoliated on a SiO<sub>2</sub>/Si substrate, it is found that two Raman modes,  $E_{2g}^1$  and  $A_{1g}$ , exhibited an anomalous thickness dependence, with the frequency of the former mode decreasing and of the latter mode increasing with the thickness.<sup>7</sup> In addition, mono-layer MoS<sub>2</sub> reveals a surprising emergence of photoluminescence,<sup>6,8</sup> which is consistent with the theoretical prediction of an indirect to direct band gap transition on going from few-layer to mono-layer MoS<sub>2</sub>.<sup>9</sup> However, the anomalous thickness dependence of the lattice vibrations in few-layer MoS<sub>2</sub> and the reason for the direct band gap of mono-layer MoS<sub>2</sub> have not been understood so far.

In this work, we report a systematic first-principles study of the evolution of the lattice and electronic structure of few-layer MoS<sub>2</sub> as a function of the number of S–Mo–S layers  $N = 1, 2, \dots, 6$ . We find that the interlayer interaction plays an important role for the properties of the system. The anomalous behaviour of the

lattice vibrations is due to a reduction of the interlayer coupling, *i.e.*, elongation of the interlayer distance, with decreasing  $N$ . The emergence of strong photoluminescence in mono-layer MoS<sub>2</sub> is due to a complete absence of interlayer interaction, which shifts the valence band at the  $\Gamma$  point to lower energy.

## II. Computational details

We addressed the electronic and vibrational properties of MoS<sub>2</sub> using the Quantum-ESPRESSO package<sup>10</sup> in the framework of density functional theory.<sup>11,12</sup> Norm-conserving pseudopotentials<sup>13</sup> (Troullier–Martins type<sup>14</sup>), as well as the generalized gradient approximation (GGA) in the Perdew–Burke–Ernzerhof<sup>15</sup> parametrization of the exchange correlation functional were employed. A high cutoff energy of 80 Ry and a precise k-point sampling ( $8 \times 8 \times 2$  grid for the bulk,  $8 \times 8 \times 1$  grid for all of the layered systems) allow us to achieve high accuracy results for the lattice constants, electronic structure and vibrational properties. Vibrational frequencies can be efficiently determined by first order response theory.<sup>12</sup> The estimated self-consistency energy error is less than  $10^{-12}$  Ry. Structure relaxation was continued until the total energy changed by less than  $10^{-5}$  Ry and the components of the forces were smaller than  $10^{-4}$  dyn cm<sup>-1</sup>. In order to account for the interlayer vdW interaction, we applied the long range dispersion correction of ref. 16. Note that this scheme does not correct electronic effects related with the vdW interaction. The calculated *a* lattice parameter of 3.194 Å is consistent with the experimental value of 3.160 Å and also the *c* lattice parameter of 6.223 Å is close to the experimental value of 6.147 Å after the inclusion of the vdW interaction.

## III. Results and discussion

Bulk MoS<sub>2</sub> has a direct (indirect) band gap of 1.96 eV (1.29 eV) and therefore does not exhibit the complexity associated with the non-adiabatic electron–phonon coupling present in graphene. Yet, recent studies of few-layer graphene let us expect that also

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the physical properties of atomically thin MoS<sub>2</sub> samples depend sensitively on the thickness. The structure of bulk MoS<sub>2</sub>, which belongs to the  $D_{6h}^4$  ( $P6_3/mmc$ ) space group, is similar to graphite, consisting of S–Mo–S layers stacked in ABAB order, which are bound by weak vdW interactions.

As the weak interlayer interaction couples the vibrations of neighbouring layers in a layered structure like MoS<sub>2</sub>, we obtain one Raman and one IR active mode in a given conjugate pair, with almost identical frequencies. Therefore, the frequencies of the intralayer vibrations in bulk and few-layer MoS<sub>2</sub> are expected to be close to those of mono-layer MoS<sub>2</sub>, which belongs to the  $D_{3h}$  space group. There are 9 normal modes of vibration at the  $\Gamma$  point with the irreducible representation (referring to the  $D_{3h}$  space group)  $\Gamma \equiv 2A''_2 \otimes A'_1 \otimes 2E' \otimes E''$ . In contrast, for bulk MoS<sub>2</sub> there are 18 normal modes of vibration at the  $\Gamma$  point with the irreducible representation (referring to the  $D_{6h}^4$  space group)  $\Gamma \equiv A_{1g} \otimes 2A_{2u} \otimes 2B_{2g} \otimes B_{1u} \otimes E_{1g} \otimes 2E_{2g} \otimes 2E_{1u} \otimes E_{2u}$ . Here,  $A_{2u}$  and  $E_{1u}$  are translational acoustic modes,  $A_{2u}$  and  $E_{1u}$  IR active modes,  $A_{1g}$ ,  $E_{1g}$  and  $E_{2g}$  Raman active modes, and  $2B_{2g}$  and  $B_{1u}$  silent modes. The calculated frequencies of the bulk MoS<sub>2</sub> Raman modes are 11.79, 276.40, 371.70 and 398.47 cm<sup>−1</sup> for  $E_{2g}^1$ ,  $E_{1g}$ ,  $E_{2g}^2$ , and  $A_{1g}$ , respectively.

The Raman spectra of few-layer MoS<sub>2</sub> exfoliated on a SiO<sub>2</sub>/Si substrate indicate that the two Raman modes  $E_{2g}^1$  and  $A_{1g}$

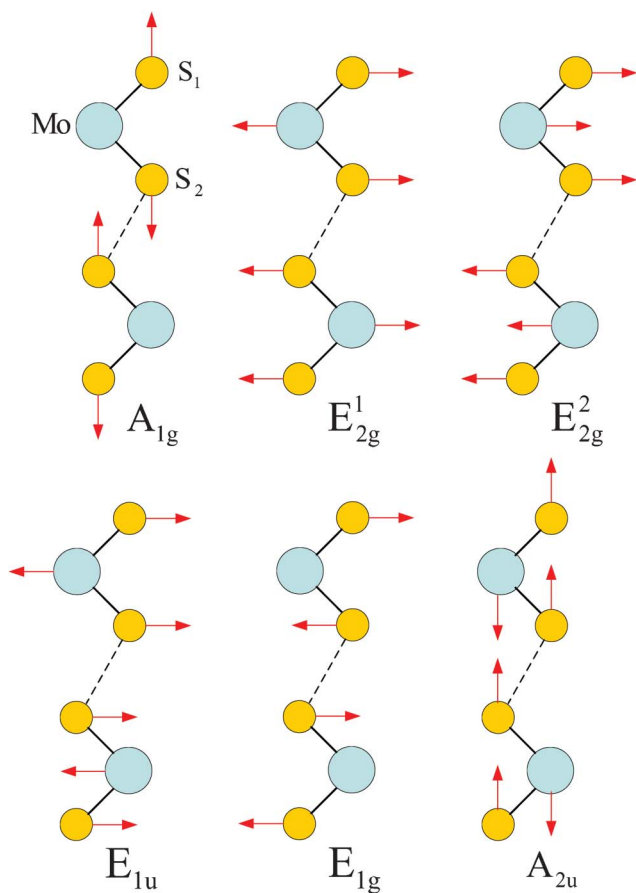
depend remarkably on the thickness  $N$ . The frequency of the  $E_{2g}^1$  mode increases and that of  $A_{1g}$  mode decreases with decreasing  $N$ .<sup>7</sup> The atom–atom interaction force model with two intralayer and one interlayer force constants<sup>17</sup> highlights the dependence of the  $E_{2g}^1$  and  $A_{1g}$  frequencies on the lattice parameters and force constants. In contrast to the experimental observations, a classical model for coupled harmonic oscillators<sup>7,18</sup> predicts that both modes become stiffer when additional layers are added. In the following we resolve this discrepancy.

As is shown in Fig. 1, the  $E_{2g}^1$  mode is the relative intraplane motion of the two S atoms and the Mo atom, while the  $A_{1g}$  mode is the relative interplane motion of the two S atoms. We study the frequency shifts with respect to the intralayer lattice parameters  $a$  and  $c$  and the interlayer distance  $c'$ . Table 1 indicates qualitative differences in the dependence of the  $A_{1g}$  and  $E_{2g}^1$  frequencies on  $a$ ,  $c$  and  $c'$ , which reflects the different motion patterns of the two modes.

Fig. 2(a) depicts the changes of  $a$ ,  $c$ , and  $c'$  (averaged over the slab) as a function of the slab thicknesses  $N$ . Combined with Table 1 these data allow us to obtain the total frequency shift as  $\Delta\omega = \frac{\partial\omega}{\partial a} \cdot \Delta a + \frac{\partial\omega}{\partial c} \cdot \Delta c + \frac{\partial\omega}{\partial c'} \cdot \Delta c'$ . The result is shown in Fig. 2(b). Due to the fact that  $\Delta c'$  increases strongly when  $N$  decreases,  $\Delta\omega$  behaves differently for the  $A_{1g}$  and  $E_{2g}^1$  modes. While the  $A_{1g}$  mode shifts to a lower frequency by 4.9 cm<sup>−1</sup> (as to compared to the bulk), the  $E_{2g}^1$  mode shifts to a higher frequency by 2.6 cm<sup>−1</sup>. This behaviour reflects the anomalous thickness dependence of the lattice vibrations reported in ref. 7, in which the authors find shifts of 3.4 cm<sup>−1</sup> and 2.3 cm<sup>−1</sup>, respectively. It is a consequence of the reduced interlayer coupling for decreasing slab thickness.

To study the interplay between the intralayer and interlayer lattice parameters, the bond lengths in mono-layer MoS<sub>2</sub> under biaxial strain and bi-layer MoS<sub>2</sub> with different interlayer distances  $c'$  are addressed in Fig. 3(a) and (b), respectively. With increasing compressive strain the S<sub>1</sub>–S<sub>2</sub> distance increases slightly, while the S–Mo distance decreases much quicker. This leads to an increase of the frequency of the  $E_{2g}^1$  mode, which corresponds to a S–Mo relative motion. When  $c'$  grows beyond its equilibrium value, the S<sub>1</sub>–S<sub>2</sub> distance increases quickly, suggesting that the frequency of the  $A_{1g}$  mode decreases with the reduction of the interlayer coupling. In addition, the S<sub>1</sub>–Mo distance (S<sub>1</sub> is located at the surface) changes only little, while the S<sub>2</sub>–Mo distance (S<sub>2</sub> is located inside the layer) decreases rapidly with increasing interlayer coupling. Consequently, the interlayer coupling has a significant effect on the atomic positions between the two layers of bi-layer MoS<sub>2</sub>.

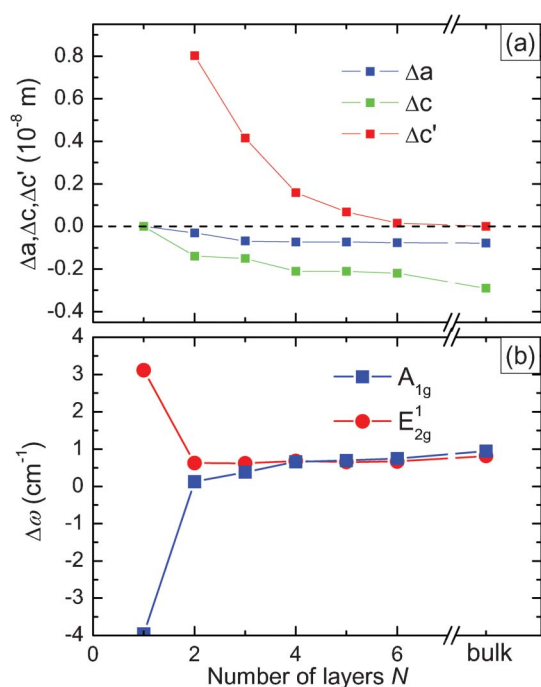
Fig. 3(c) and (d) address the atomic charges for mono-layer MoS<sub>2</sub> under biaxial strain and bi-layer MoS<sub>2</sub> for different interlayer distances  $c'$ , respectively. With increasing biaxial strain, the charge transfer of the S and Mo atoms changes slightly for mono-layer MoS<sub>2</sub>. With reduction of the interlayer



**Fig. 1** Atomic displacements of the four Raman active modes ( $A_{1g}$ ,  $E_{2g}^1$ ,  $E_{2g}^2$  and  $E_{1g}$ ) and the two IR active modes ( $E_{1u}$ ,  $A_{2u}$ ) of bulk MoS<sub>2</sub> crystal, as viewed along the [1000] direction.

**Table 1** Derivative of the frequency with respect to the lattice parameters  $a$ ,  $c$  and  $c'$

	$\frac{\partial\omega}{\partial a}$	$\frac{\partial\omega}{\partial c}$	$\frac{\partial\omega}{\partial c'}$
$A_{1g}$	−223.8	−265.9	−39.6
$E_{2g}^1$	−260.3	−210.2	31.1



**Fig. 2** (a) Changes of the intralayer lattice parameters  $a$  and  $c$  and the interlayer distance  $c'$  as a function of the slab thickness. (b) Frequency shifts of the  $A_{1g}$  and  $E_{2g}^1$  modes.

coupling ( $c'$  larger than the equilibrium interlayer distance), the Mo charge transfer decreases and the  $S_2$  charge transfer increases, while the  $S_1$  charge transfer is almost constant. This shows that interlayer coupling also strongly affects the electron distribution among the S and Mo atoms at the interface of the two layers, implying effects on the electronic properties.

Fig. 4 displays orbital projected electronic band structures of bulk  $\text{MoS}_2$ , which have been studied experimentally and theoretically.<sup>19–21</sup> Bulk  $\text{MoS}_2$  is an indirect band gap semicon-

ductor with the valence band maximum (VBM) at the  $\Gamma$ -point and the conduction band minimum (CBM) along  $K-\Gamma$ . The CBM at the  $K$ -point, as well as the VBM at the  $\Gamma$ -point are primarily composed of the Mo  $d_{z^2}$  and  $S p_z$  states, while the CBM along  $K-\Gamma$  and the VBM at the  $K$ -point are dominated by Mo  $d_{x^2-y^2}/d_{xy}$  and  $S p_x/p_y$  states. The Mo  $d_{xz}/d_{yz}$  states are found far off the Fermi energy.

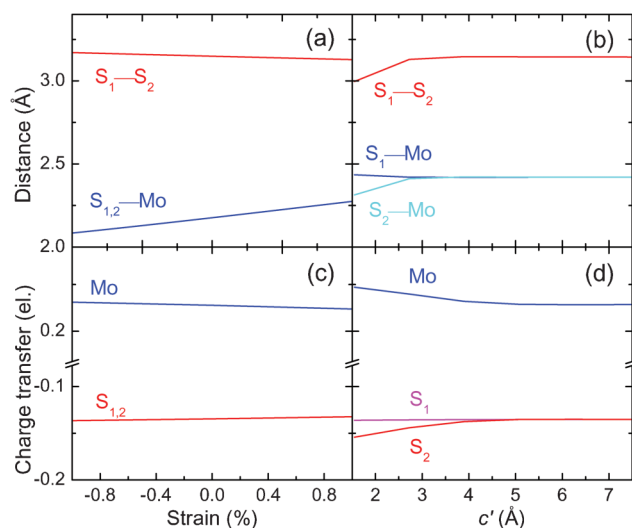
Recently, few-layer  $\text{MoS}_2$  has been characterized by absorption, photoluminescence and photoconductivity experiments.<sup>6,8</sup> It has been found that with decreasing thickness the indirect band gap shifts upwards in energy by more than 0.6 eV, which leads to a crossover to a direct band gap in the mono-layer limit. The indirect to direct band gap transition was attributed to perpendicular quantum confinement and explained by applying a zone-folding scheme for ultra thin samples. It is, however, not clear why only mono-layer  $\text{MoS}_2$  is a direct band gap semiconductor, while thicker layers of  $\text{MoS}_2$  ( $N \geq 2$ ) still exhibit an indirect band gap character.

Fig. 5(a) shows the variations of the CBM at the  $K$ -point and along  $K-\Gamma$  and of the VBM at the  $\Gamma$  and  $K$ -points with respect to the number of S–Mo–S layers. Our results are qualitatively consistent with experimental, as well as previous theoretical findings.<sup>5,6,8,21</sup> The direct excitonic transition energy at the  $K$ -point barely changes with decreasing thickness  $N$ , whereas the indirect band gap increases by almost exactly 0.6 eV (which is the experimental value<sup>8</sup>) from the bulk to the mono-layer system. We notice that there is a sudden decrease of the VBM at the  $\Gamma$ -point from bi-layer to mono-layer  $\text{MoS}_2$ . In the mono-layer system there is, of course, no interlayer coupling, whereas interlayer coupling still exists in few-layer  $\text{MoS}_2$ . We can conclude that the absence of interlayer coupling is the origin of the direct band gap of mono-layer  $\text{MoS}_2$ .

To illustrate the influence of the interlayer coupling on the electronic states of few-layer  $\text{MoS}_2$ , we examine the variation of the band structure as a function of the interlayer distance  $c'$  in bi-layer  $\text{MoS}_2$ , see Fig. 5(b). Significant changes take place at the top of the valence band, where the VBM at the  $\Gamma$ -point drops substantially when  $c'$  increases. For decreasing interlayer interaction the Mo  $d_{z^2}$  and  $S p_z$  states (which mediate the interlayer coupling) shift to lower energy. The downward shift of these valence states not only results in an increase of the band gap, but also changes its nature from indirect to direct.

It is known that the interlayer interaction in graphene seriously affects the topology of the  $\pi$  bands, going from the mono-layer's 2D character to a 3D character for a multi-layer structure.<sup>22</sup> The changes of the electronic structure and electron–phonon interaction are reflected by Raman fingerprints.<sup>23</sup> Recently, mono-layer silicon (silicene) has been fabricated and a Dirac point has been observed.<sup>24,25</sup> Silicene therefore is another prominent example of a material in which the absence of interlayer interaction induces strong changes in the electronic structure. As compared to both graphene and silicene, mono-layer  $\text{MoS}_2$  has a more complicated structure. However, the interlayer interaction plays a similarly important role for the electronic structure and vibrational properties.

In fact,  $\text{MoS}_2$  is member of a large family of structurally and chemically very closely related transition metal dichalcogenides. Its mono-layer structure results in a unique optical behaviour related to the  $d$ -electron character of its valence and conduction



**Fig. 3** Bond distances (top) and charge transfers (bottom) for (a)/(c) mono-layer  $\text{MoS}_2$  under biaxial strain and (b)/(d) bi-layer  $\text{MoS}_2$  as a function of the interlayer distance  $c'$ .



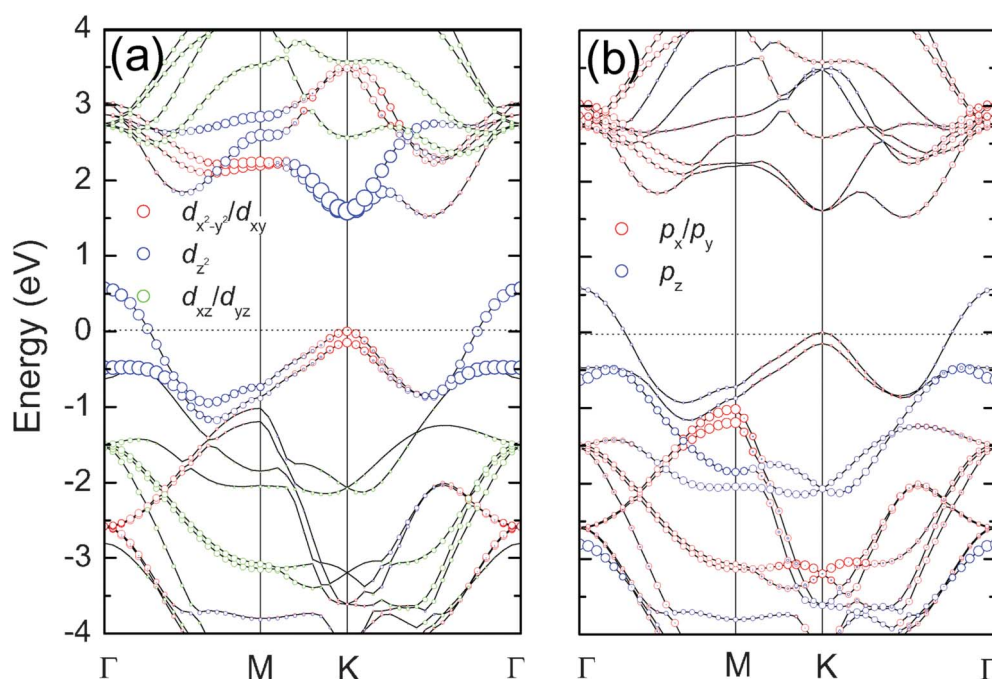


Fig. 4 (a) Mo and (b) S orbital projected electronic band structures of bulk MoS<sub>2</sub>.

orbitals. In addition, few-layer MoS<sub>2</sub> shows an anomalous behaviour of the lattice vibrations in the sense that the frequency of the  $E_{2g}^1$  mode decreases and that of  $A_{1g}$  mode increases with increasing layer thickness. It is expected that other members of the transition metal dichalcogenides with indirect band gaps, such as HfS<sub>2</sub>, MoSe<sub>2</sub> and WS<sub>2</sub>, exhibit a similar behaviour of the lattice vibrations and electronic properties when the layer thickness decreases. Metallic transition metal dichalcogenides, such as TaS<sub>2</sub> and NbSe<sub>2</sub>, in contrast should not behave like MoS<sub>2</sub>.

#### IV. Conclusion

In conclusion, we have discussed the effects of interlayer coupling on the vibrational and electronic properties of few-layer MoS<sub>2</sub> based on *ab initio* calculations. When the number of S–Mo–S layers decreases, we find that the interlayer distance elongates significantly, *i.e.* the interlayer coupling is reduced. We have shown that the anomalous thickness dependence of the lattice vibrations in few-layer MoS<sub>2</sub> is a consequence of these alterations of the interlayer coupling. In addition, the absence of interlayer coupling in mono-layer MoS<sub>2</sub> explains the fact that only this system has a direct band gap, while even for bi-layer MoS<sub>2</sub> the band gap is indirect. We note that anharmonic effects often are large for low frequencies.<sup>26</sup> However, our line of reasoning is not affected by them as it is based on frequency shifts only. Our findings highlight that new vibrational and electronic properties, probably as exciting as those of graphene, can be expected from an ultra thin slab of vdW bounded compounds with more complex intralayer chemical structure.

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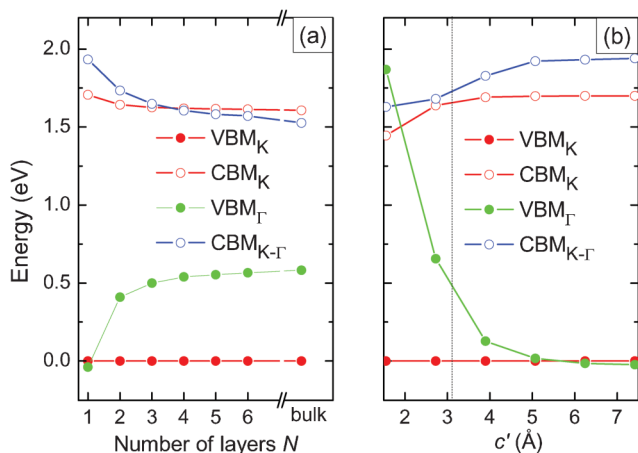


Fig. 5 Variation of the CBM and VBM with respect to (a) the number of layers  $N$  and (b) the distance  $c'$  between the two layers of bi-layer MoS<sub>2</sub>. CBM<sub>K</sub> refers to the K-point and CBM<sub>K-Γ</sub> to the path K–Γ, compare Fig. 4. VBM<sub>K</sub> and VBM<sub>G</sub> refer to the K-point and Γ-point, respectively.

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